

SEMICONDUCTOR®

# FQP22N30 N-Channel QFET<sup>®</sup> MOSFET

**300 V, 21 A, 160 m**Ω

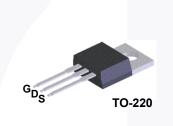
### Description

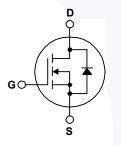
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

### Features

- 21 A, 300 V,  ${\sf R}_{{\sf DS}({\sf on})}$  = 160 m $\Omega$  (Max.) @ V\_{{\sf GS}} = 10 V,  ${\sf I}_{\sf D}$  = 10.5 A
- Low Gate Charge (Typ. 47 nC)
- Low Crss (Typ. 40 pF)
- 100% Avalanche Tested

November 2013





### Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted.

Symbol	Parameter		FQP22N30	Unit
V <sub>DSS</sub>	Drain-Source Voltage		300	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^\circ$	C)	21	A
	- Continuous (T <sub>C</sub> = 100	°C)	13.3	A
DМ	Drain Current - Pulsed	(Note 1)	84	A
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	1000	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	21	A
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	17	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
PD	Power Dissipation ( $T_C = 25^{\circ}C$ )		170	W
	- Derate above 25°C		1.35	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C

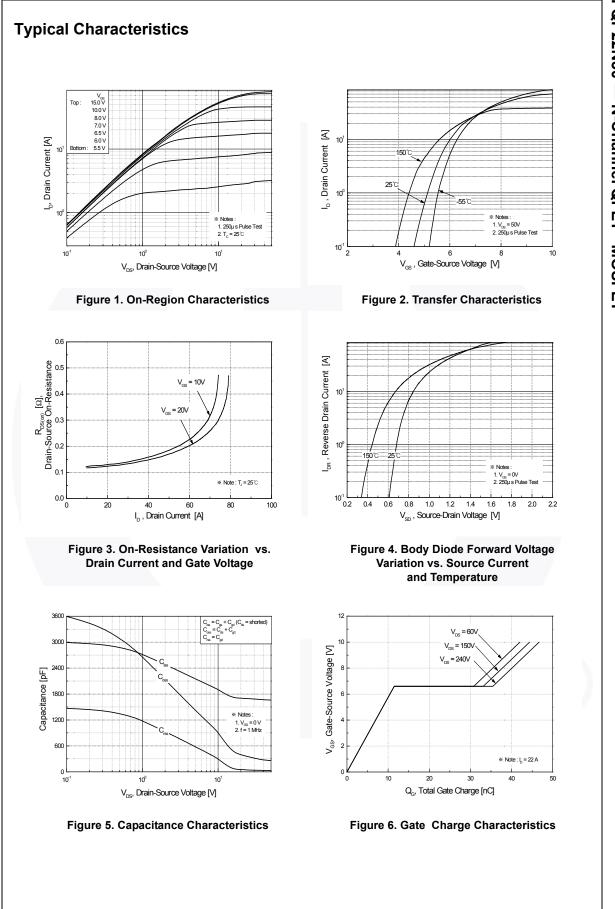
## **Thermal Characteristics**

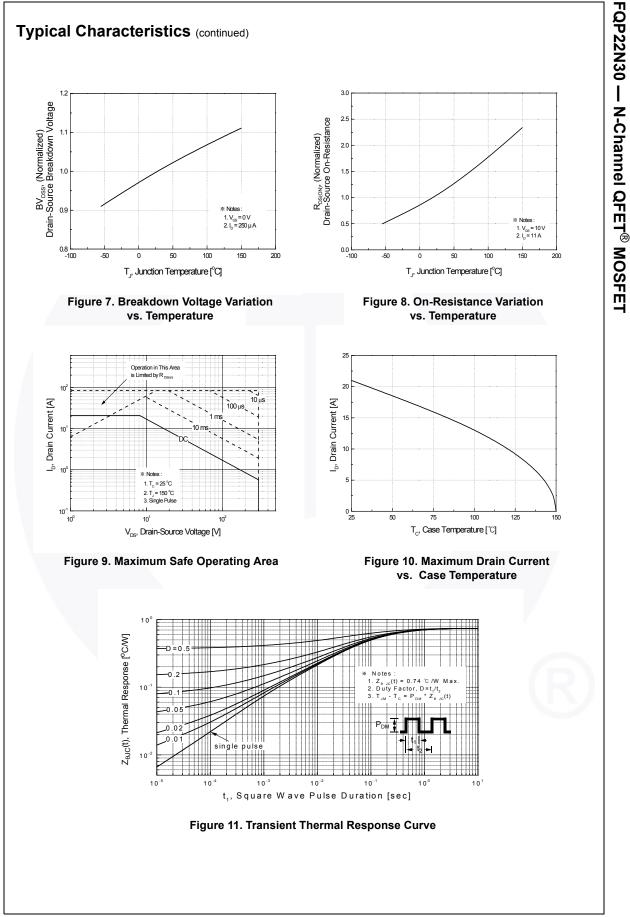
Symbol	Parameter	FQP22N30	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.74	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	°C/W

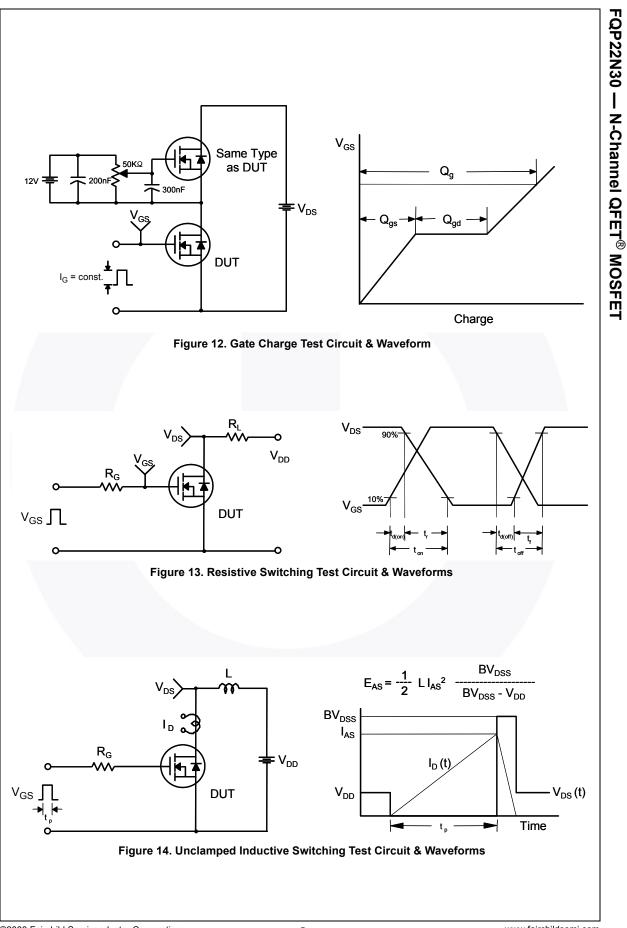
Part NumberTop MarkPackageFQP22N30FQP22N30TO-220		Packing Method	Reel Size	Tape Width		h Q	Quantity		
		Tube N/A		N/A		5	50 units		
lectri	cal C	haracteristics	T <sub>C</sub> = 25°C	unless otherwise noted.					
Symbol		Parameter		Test Condit	ions	Min	Тур	Max	Unit
Off Cha	aracto	rietice							
BV <sub>DSS</sub>			oltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 µ	ιA	300			V
$\Delta BV_{DSS}$	Breakdown Voltage Temperature		•			000			
$/ \Delta T_{J}$			$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$			0.3		V/°C	
I <sub>DSS</sub>	7			$V_{DS}$ = 300 V, $V_{GS}$ = 0	) V			1	μA
	Zero C	Gate Voltage Drain Co	urrent	$V_{DS} = 240 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$			-	10	μA
I <sub>GSSF</sub>	Gate-E	Body Leakage Currer	nt, Forward	$V_{GS}$ = 30 V, $V_{DS}$ = 0	V			100	nA
I <sub>GSSR</sub>	Gate-E	Body Leakage Currer	nt, Reverse	$V_{GS}$ = -30 V, $V_{DS}$ = 0	V			-100	nA
On Ch	rocto	viation							
On Cha V <sub>GS(th)</sub>	1	Tistics Threshold Voltage		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250	цА	3.0		5.0	V
		Drain-Source				3.0		5.0	v
R <sub>DS(on)</sub>		esistance		$V_{GS} = 10 \text{ V}, I_D = 10.5$	δA		0.12	0.16	Ω
9 <sub>FS</sub>	Forwa	rd Transconductance	•	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 10.5	5 A		16		S
D	ia Cha								
							1700	0000	- 5
C <sub>iss</sub>		Capacitance		$V_{DS} = 25 V, V_{GS} = 0$	V,		1700	2200	pF
C <sub>oss</sub>		t Capacitance		f = 1.0 MHz			350	450	pF
C <sub>rss</sub>	Revers	se Transfer Capacita	lice				40	50	pF
Switch	ing Ch	aracteristics							
t <sub>d(on)</sub>	Turn-C	On Delay Time		$V_{DD}$ = 150 V, I <sub>D</sub> = 22 A, R <sub>G</sub> = 25 $\Omega$			35	80	ns
t <sub>r</sub>	Turn-C	On Rise Time					230	470	ns
t <sub>d(off)</sub>	Turn-C	Off Delay Time					85	180	ns
t <sub>f</sub>	Turn-C	Off Fall Time			(Note 4)	/	100	210	ns
Qg	Total C	Gate Charge		V <sub>DS</sub> = 240 V, I <sub>D</sub> = 22	Α.		47	60	nC
Q <sub>gs</sub>	Gate-S	Source Charge		V <sub>GS</sub> = 10 V			12		nC
Q <sub>gd</sub>	Gate-I	Drain Charge			(Note 4)		24	-	nC
				d Maximum Rati	ngs				
I <sub>S</sub>		um Continuous Drai						21	A
I <sub>SM</sub>	-	um Pulsed Drain-So						84	A
V <sub>SD</sub>		Source Diode Forwar	rd Voltage	$V_{GS} = 0 V, I_S = 21 A$				1.5	V
t <sub>rr</sub>		se Recovery Time		$V_{GS} = 0 V, I_{S} = 22 A,$			215		ns
Q <sub>rr</sub>	Rever	se Recovery Charge		$dI_F / dt = 100 A/\mu s$			1.6		μC

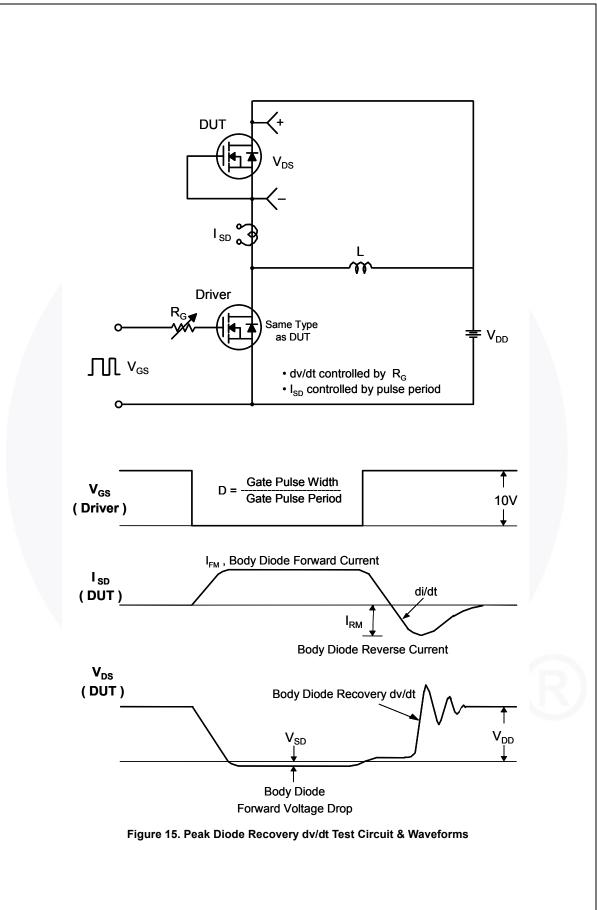
4. Essentially independent of operating temperature.

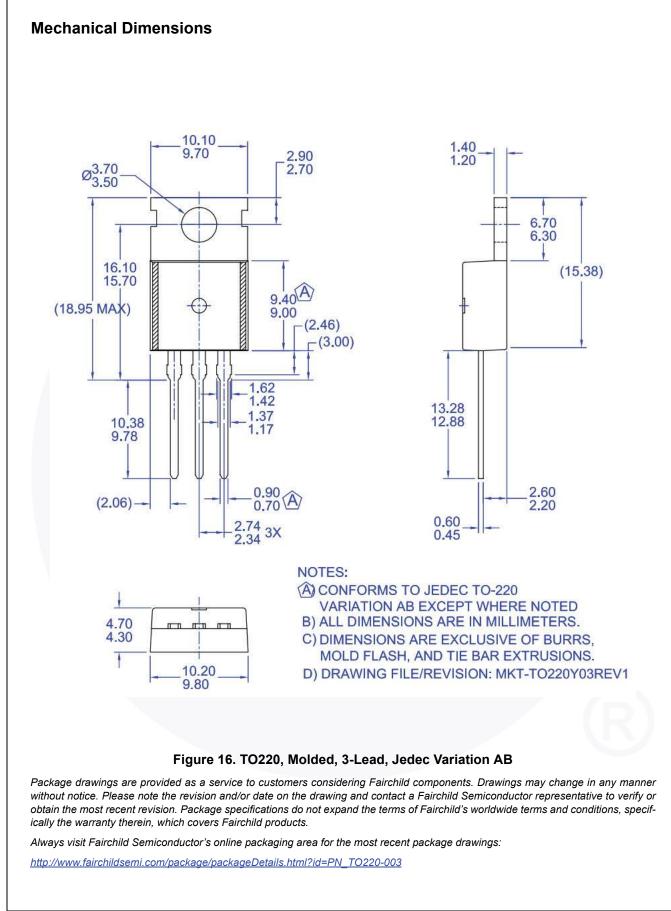
FQP22N30 — N-Channel QFET<sup>®</sup> MOSFET













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